MNDSPD.0005P

PATENT

TATES PATENT AND TRADEMARK OFFICE

Applicant	:	Jones, et al.)	Group Art Unit: 2857
App. No.	j.	09/810,932)	
Filed	:	March 16, 2001)	I hereby certify that this correspondence and all
For	:	METHOD AND APPARATUS FOR TRANSMISSION LINE ANALYSIS	,	marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on
Examiner	:	Unknown)	January 29, 2002
			,	Chad/WI Miller, Reg. No. 44,943

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Enclosed is form PTO-1449 listing references that are also enclosed. This Information Disclosure Statement is being filed before the mailing of the first Office Action on the merits, and as such, no fee is required in accordance with 37 C.F.R. § 1.97(b)(3).

Respectfully submitted,

Chad W. Miller

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			SHEET I OF
ORM PTO-142 U.S. DEPARTMENT OF COMMERCE	ATTY. DOCKET NO.	APLICATION NO.	
PATENT AND TRADEMARK OFFICE	MNDSPD.0005P	09/810,932	
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BY APPLICANT	FILING DATE	GROUP	
(USE SEVERAL SHEETS IF NECESSARY)	March 16, 2001	2857	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
				9.4			

	FOREIGN PATENT DOCUMENTS						
EXAMINER	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANS	LATION
INITIAL						YES	NO
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			M 1/1 A				

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
	Taylor, V. and Faulkner, M.; Line Monitoring and Fault Location Using Spread Spectrum on Power Line Carrier; Published in IEE Proc
JRW	Gener. Transm. Distrib., Vol. 143, No. 5, September 1996; Pages 427-434
	Hwang, L., Rinne, G. and Turlik, I.; An Extended Time-Domain Network Analysis Measurement Technique; Published in IEEE
ORW	Transactions on Components, Packaging, and Manufacturing Technology, Part B, Vol. 18, No. 2, May 1995; Pages 375-380.
	Dhaene, T., Martens, L. and Zutter, D.; Calibration and Normalization of Time Domain Network Analyzer Measurements; Published in
Strw	IEEE Transactions on Microwave Theory and Techniques, Vol. 42, No. 4, April 1994; Pages 580-589.

Cwm-1119.1

EXAMINER

DATE CONSIDERED

*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

			SHEET 2 OF
FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. MNDSPD.0005P	APPLICATION NO. 09/810,932	
INFORMATION DISCLOSURE CITATION BY APPLICANT	APPLICANT(S) Jones, et al.		
(USE SEVERAL SHEETS IF NECESSARY)	FILING DATE March 16, 2001	GROUP ART UNIT 2857	

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
	Hayden, L. and Tripathi, V.; Calibration Methods for Time Domain Network Analysis; Published in IEEE Transactions on Microwave Theor
TRW	and Techniques, Vol. 41, No. 3, March 1993; Pages 415-420
	Su, W., and Riad, S.; Calibration of Time Domain Network Analyzers; Published in IEEE Transactions on Instrumentation and
JRW	Measurement, Vol. 42, No. 2, April 1993; Pages 157-161.
5PW	Boets, P. and Van Biesen, L.; The Modelling Aspect of Transmission Line Networks; 1992; Pages 137-141.
JRW	Munk, A. and Cusick, J.; A Time Domain Analysis of a Calibration Error Model; 1991; Pages 22-26.
	Pintelon, R., and Van Biesen, L.; Identification of Transfer Functions With Time Delay and Its Application to Cable Fault Location;
JRW	Published in IEEE Transactions on Instrumentation and Measurement, Vol. 39, No. 3, June 1990; Pages 479-484.
	Van Biesen, L., Renneboog, J. and Barel, A.; High Accuracy Location of Faults on Electrical Lines Using Digital Signal Processing;
JRW	Published in IEEE Transactions on Instrumentation and Measurement, Vol. 39, No. 1, February 1990; Pages 175-179.

EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.